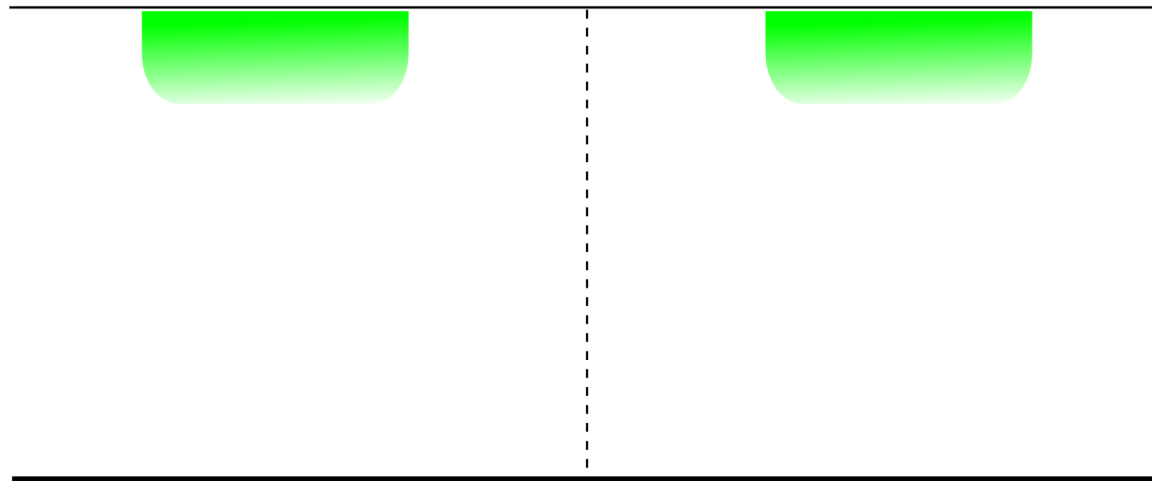


“Eta” correction of systematic measurement bias

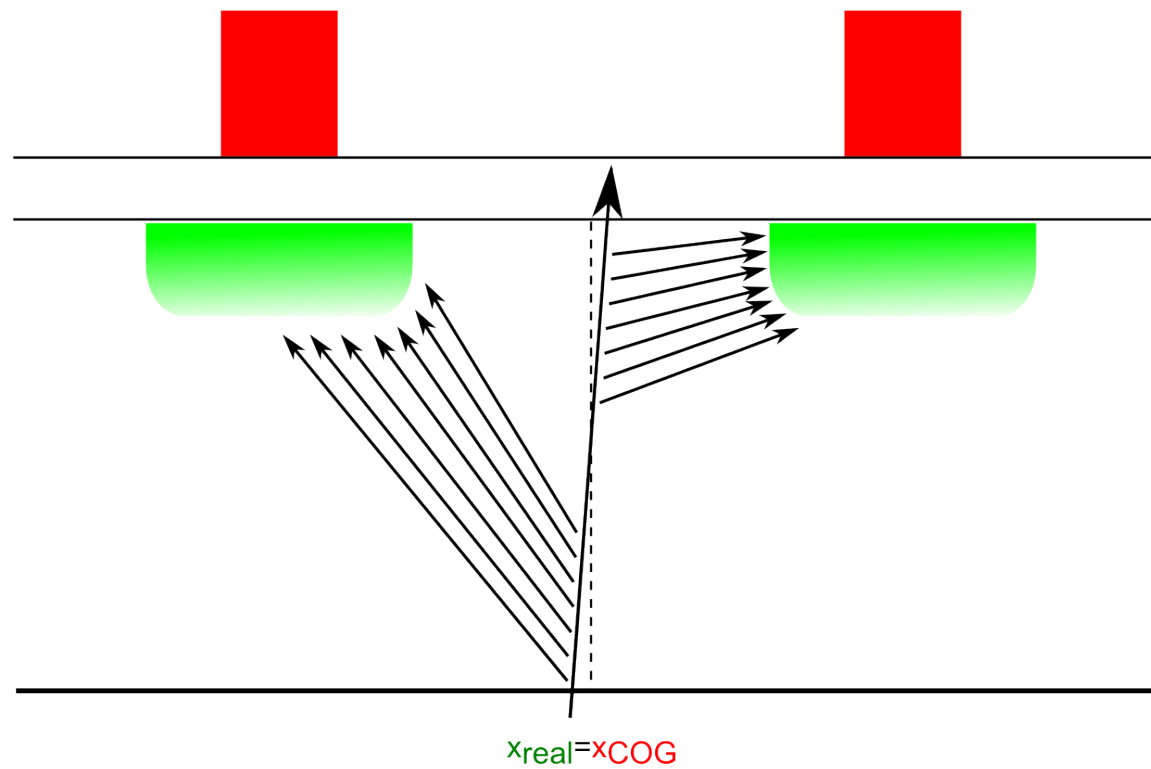
Manfred Valentan

MPP Munich

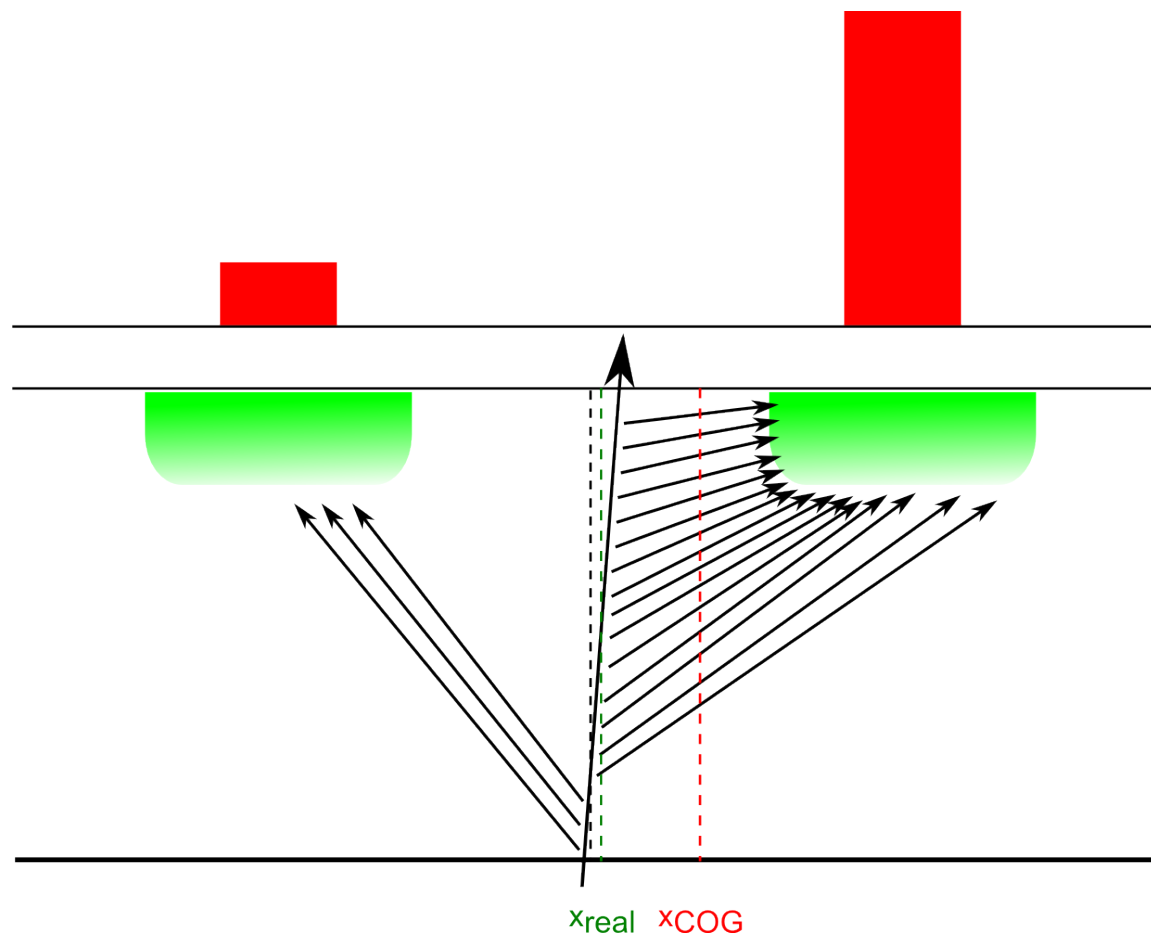
Nonlinear charge collection



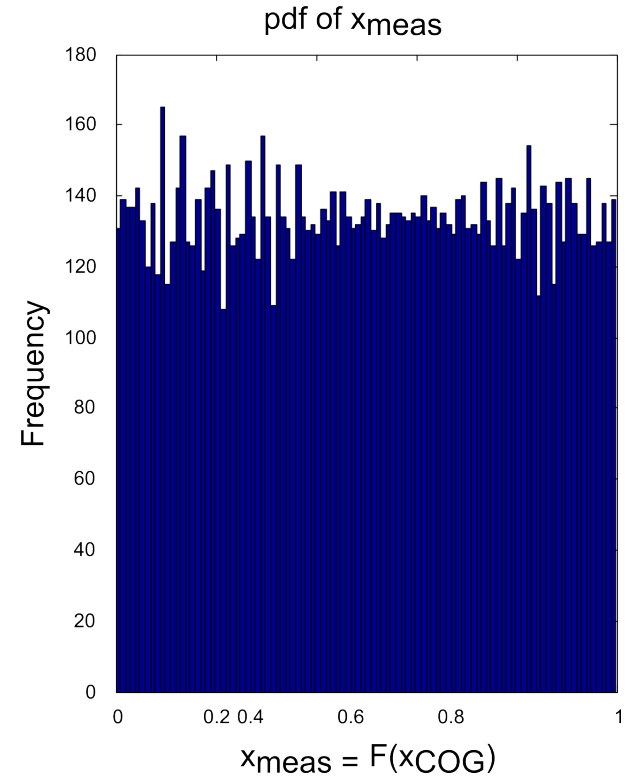
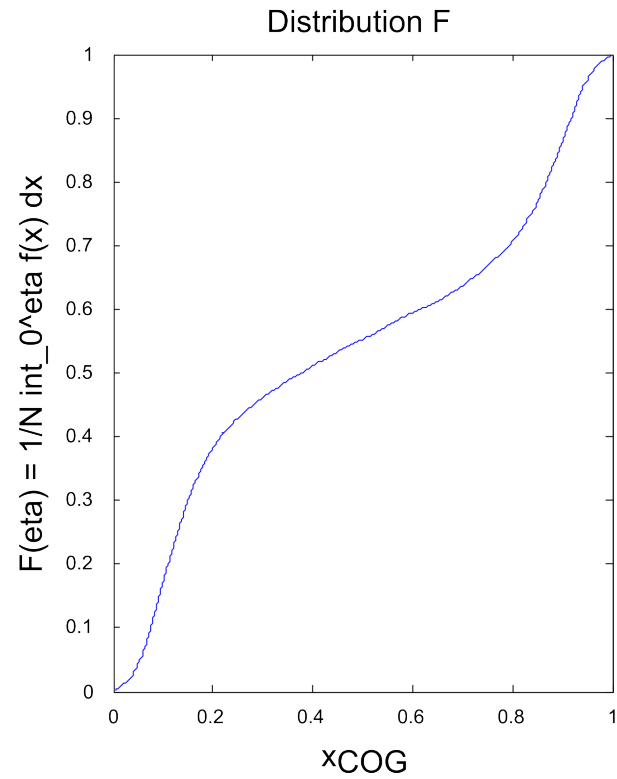
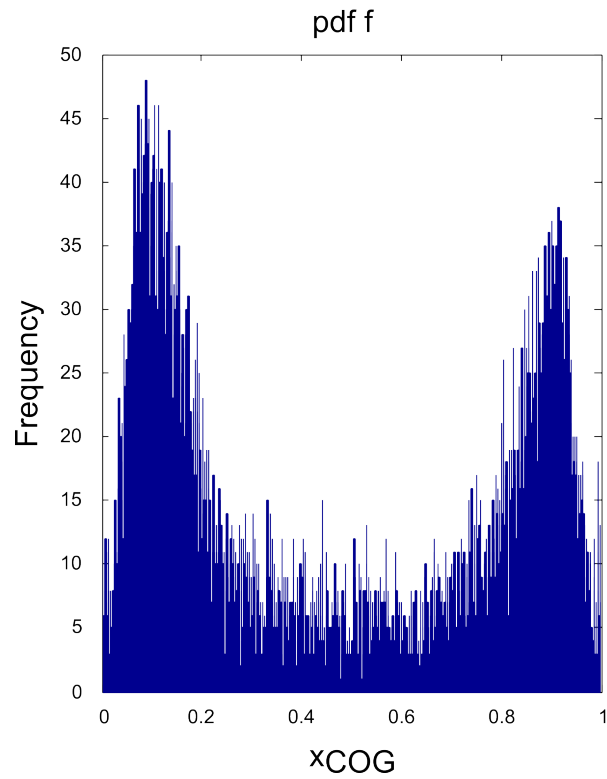
Nonlinear charge collection



Nonlinear charge collection



Eta ($=x_{\text{COG}}$) correction



Where does this fit in?

- After track finding, before track fitting
 - On the level of digits
- Need impact angle information
 - From track finding and geometry
- Store correction data
 - Addition to alignment or calibration?

What is the benefit? (Assumptions)

- More reliability for single tracks
 - Not only statistical average
- Improved vertexing
 - Without it measurements can be pitch/3 off
- Changes e.g. impact parameter distribution
 - More realistic
- Improved fit quality
 - Data better matches model → better Chi2 prob.

What I need

- Realistic digitizers
 - Both DEPFET sensors and DSSDs
- Directions and tips
 - How to interface to alignment runs to calculate the correction data
 - How to store the correction data
 - Where to apply the correction
 - Addition after track finding? Addition before track fitting? Standalone?
- What do you think?